



Anti-surge thin film chip resistors

MRG series

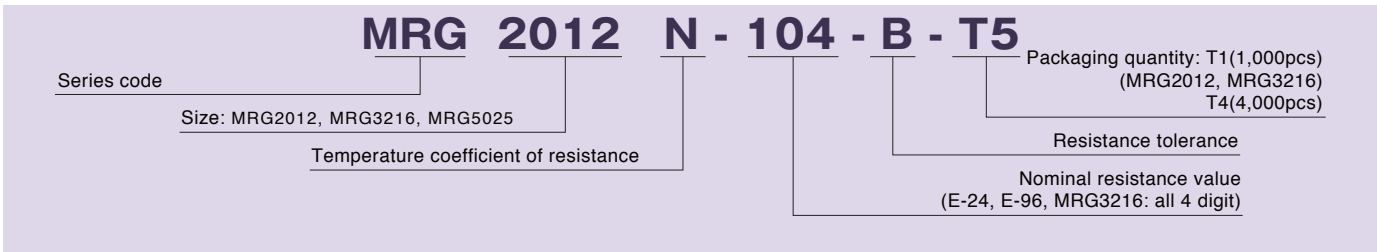
Features

- Significant improvement of anti-surge capability comparing to existing thin film resistors
- Precision resistance tolerance: $\pm 0.1\%$, very small TCR: $\pm 10\text{ppm}/^\circ\text{C}$
- Thin film structure enabling low noise and anti-sulfur

Applications

- Power source related devices
- Automotive electronics
- Robotics, Industrial control system

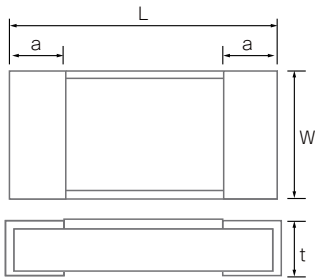
Part numbering system



Electrical Specification

Type	Power ratings	Temperature coefficient of resistance (ppm/ $^\circ\text{C}$)	Resistance range(Ω) Resistance tolerance		Maximum voltage	Resistance value series	Operating temperature	Packaging quantity
			$\pm 0.1\%$ (B)	$\pm 0.5\%$ (D)				
MRG2012	1/10W	± 10 (N)	$100 \leq R \leq 1\text{M}$		150V	E-24, E-96	$-55^\circ\text{C} \sim 155^\circ\text{C}$	T5
		± 25 (P)						
MRG3216	1/8W	± 10 (N)	$100 \leq R \leq 2\text{M}$		200V	E-24, E-96	$-55^\circ\text{C} \sim 155^\circ\text{C}$	T5
		± 25 (P)						
MRG5025	1/2W	± 10 (N)	$100 \leq R \leq 2\text{M}$		300V	E-24, E-96	$-55^\circ\text{C} \sim 155^\circ\text{C}$	T4
		± 25 (P)						

Dimensions



Type	Size (inch)	L	W	a	t
MRG2012	0805	2.00 ± 0.20	$1.25 + 0.25 / - 0.20$	0.40 ± 0.20	$0.40 + 0.15 / - 0.10$
MRG3216	1206	3.20 ± 0.20	1.60 ± 0.25	0.50 ± 0.25	$0.40 + 0.15 / - 0.10$
MRG5025	2010	5.00 ± 0.20	2.50 ± 0.25	0.60 ± 0.25	$0.45 + 0.15 / - 0.10$

(unit : mm)

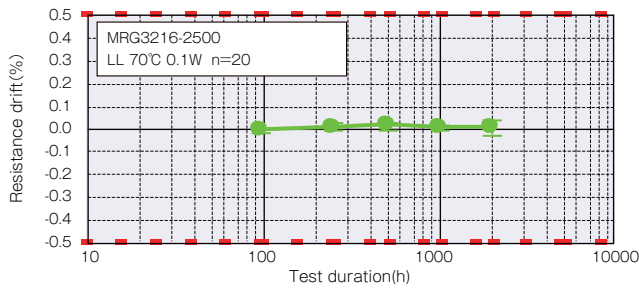
◆ Reliability specification

Test items	Condition (test methods (MIL-PRF-55342/JIS C5201-1))	Standard
Short time overload	2.5 x rated voltage, ^{*1} 5seconds	±0.05%
Life (biased)	85°C, rated voltage, ^{*1} 90min on 30min off, 2000hours	±0.25%
High temperature high humidity	85°C, 85%RH, 1/10 of rated power, 90min on 30min off, 2000hours	±0.25%
Temperature shock	-55°C (30min) ~ 125°C (30min) 2000cycles	±0.1%
High temperature exposure	155°C, no bias, 2000hours	±0.5%
ESD (HBM)	4KV (Positive 3times, negative 3 times)	±0.5%
Resistance to soldering heat	260±5°C, 10 seconds (reflow)	±0.1%

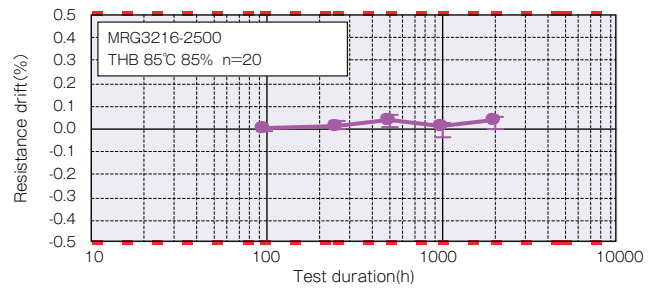
*1 Rated voltage is given by $E = \sqrt{R \times P}$ E= rated voltage (V), R=nominal resistance value(Ω), P=rated power(W)
If rated voltage exceeds maximum voltage /element, maximum voltage/element is the rated voltage.

◆ Reliability test data

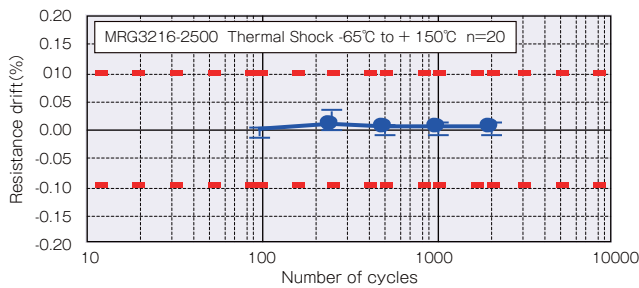
○ Biased life test



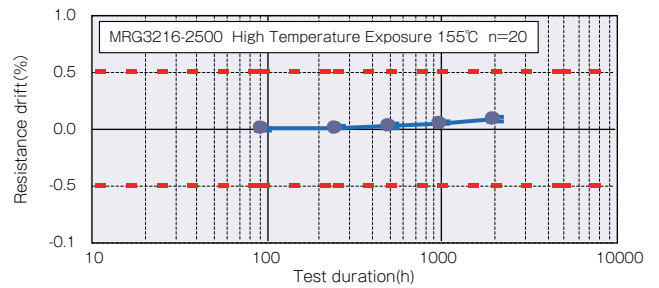
○ High temperature high humidity (biased)



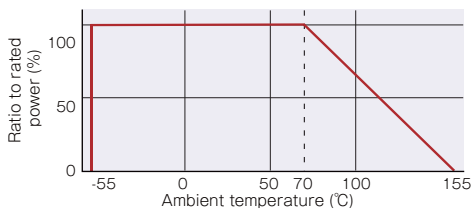
○ Temperature shock



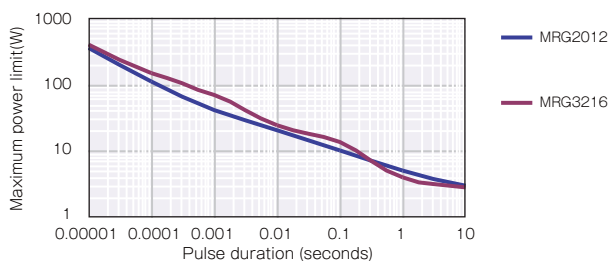
○ High temperature exposure



◆ Derating Curve



◆ Maximum pulse power limit (single pulse)



◆ Maximum pulse power limit (multiple pulses)

